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July 30, 2004

To: Commissioner for Patents

P.O.Box 1450

Alexandria, VA 22313-1450

Fr: George O. Saile, Reg. No. 19,572

28 Davis Avenue

Poughkeepsie, N.Y. 12603

Subject:

Serial No. 10/849,311 05/19/04

Liubo Hong et al.

MRAM CELL STRUCTURE AND METHOD OF

FABRICATION

INFORMATION DISCLOSURE STATEMENT

Enclosed is Form PTO-1449, Information Disclosure Citation
In An Application.

The following Patents and/or Publications are submitted to comply with the duty of disclosure under CFR 1.97-1.99 and 37 CFR 1.56.

CERTIFICATE OF MAILING

I hereby certify that this correspondence is being deposited with the United States Postal Service as first class mail in an envelope addressed to: Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450, on August ¶ , 2004.

Stephen B. Ackerman, Reg.# 37761

Signature/Date

HT-03-038

- U.S. Patent 6,384,482 to Yang et al., "Method for Forming a Dielectric Layer in a Semiconductor Device by Using Etch Stop Layers," discloses a method for forming a dielectric layer in a semiconductor device by using etch stop layers.
- U.S. Patent 6,673,675 to Yates et al., "Methods of Fabricating an MRAM Device Using Chemical Mechanical Polishing," discloses a method for a CMP process involving an MRAM cell in which a WN or TaN layer is used as a cap layer on a MTJ and also functions as a series resistor or as a CMP stop layer.
- U.S. Patent 6,174,737 to Durlam et al., "Magnetic Random Access Memory and Fabricating Method Thereof," discloses CMP before forming MTJ. A dielectric layer is deposited over the MTJ elements, then openings are etched to the elements.
- U.S. Patent 6,649,953 to Cha, "Magnetic Random Access

 Memory Having a Transistor of Vertical Structure with Writing

 Line Formed on an Upper Portion of the Magnetic Tunnel Junction

 Cell," discloses a method of polishing of the dielectric layer

 to expose the MTJ elements.

Sincerely

Stephen B. Ackerman,

Reg. No. 37761

Doctor (Cperina) Form PTO-1449 NATION DISCLOSURE CITATION IN AN APPLICATION 1 2004 UB overal shouls il necessary) U. S'. PATENT DOCUMENTS DATE HULE CLASS FLAND DATE

* APPROPRIATE **WISCULE** 758 438 438 3 295 257 FOREIGN PATENT DOCUMENTS Translation DOCUMENT NUMBER OATE COUNTRY cuss **EZAJOUZ** OTHER DOCUMENTS (Including Author, Title, Dale, Pertinent Pages, Elc.) EXAMMER DATE CONCOERED EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP § 609; Draw line through

citation if not in conformance and not considered. Include copy of this form with next communication to the applicant